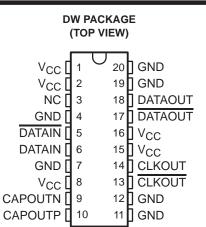
# TNETA1622 622.08-MHz CLOCK-RECOVERY DEVICE

SDNS017C - FEBRUARY 1994 - REVISED DECEMBER 1995

- Recovers a 622.08-MHz Clock Signal From a 622.08-Mbit/s STS-12/STM-4 NRZ Data Stream
- Accepts Pseudo-ECL (PECL) Input Voltage Levels on the Input Data Stream
- Requires a Single 5-V Supply
- Provides PECL-Clock and PECL-Data Outputs

## description

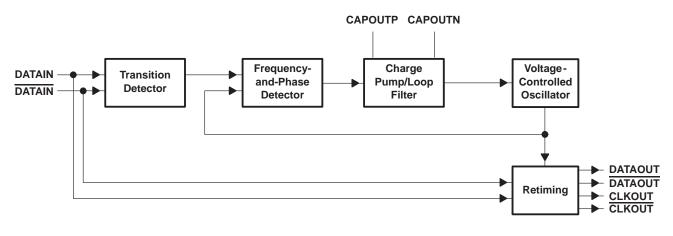
The TNETA1622 recovers an embedded clock signal from a 622.08-Mbit/s STS-12/STM-4 nonreturn-to-zero (NRZ) data stream using a frequency/phase-locked loop. The device accepts PECL (ECL signals referenced to 5 V instead of GND) input-voltage levels. The recovered clock and data outputs are PECL compatible. The serial data input and recovered clock and data outputs are differential to provide maximum noise immunity.



NC - No internal connection

The TNETA1622 requires only a positive 5-V supply (5 V  $\pm$  5%) for operation. The TNETA1622 is characterized for operation over a temperature range of  $-40^{\circ}$ C to 85°C.

## functional block diagram





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#### TERMINAL 1/0 DESCRIPTION NAME NO. CAPOUTN 9 I Capacitor connection for phase-locked-loop filter CAPOUTP 10 CLKOUT 13 0 Recovered clock output, PECL compatible CLKOUT 14 DATAIN 5 I Serial data input, PECL compatible DATAIN 6 DATAOUT 17 Ο Serial data output, PECL compatible DATAOUT 18 4, 7, 11, 12, GND Ground (0-V reference) 19,20 1, 2, 8, 15, 16 Vcc Supply voltage NC 3 No connection. Leave floating (open).

## **Terminal Functions**

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, V <sub>CC</sub> (see Note 1)	–0.5 V to 7 V
Input voltage range, VI, PECL	0 V to 7 V
Power dissipation	562 mW
Operating free-air temperature range, T <sub>A</sub>	–40°C to 85°C
Storage temperature range, T <sub>stg</sub>	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
NOTE 1: All voltage values are with respect to the GND terminals.

## recommended operating conditions

			MIN	NOM	MAX	UNIT
VCC	V <sub>CC</sub> Supply voltage		4.75	5	5.25	V
VIH	High-level input voltage	PECL (see Note 2)	V <sub>CC</sub> -1.15		V <sub>CC</sub> -0.80	V
$V_{IL}$	Low-level input voltage	PECL (see Note 2)	V <sub>CC</sub> -1.90		V <sub>CC</sub> -1.50	V
TA	Operating free-air temperature		- 40		85	°C

NOTE 2: The algebraic convention, in which the least positive (most negative) value is designated minimum, is used in this data sheet for logic-level voltages only.



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## electrical characteristics over recommended ranges of operating free-air temperature and supply voltage (unless otherwise noted) (see Figure 1)

PARAMETER			TEST CONDITIONS	MIN	TYP MAX	UNIT
VOH	High-level output voltage	DATAOUT, DATAOUT	$V_{CC} = 4.75 V \text{ to } 5.25 V,$ See Notes 2 and 3 $V_{CC} = 1.03 V_{CC} = 0.8$		V <sub>CC</sub> -0.85	V
VOL	Low-level output voltage	<u>DATAOUT,</u> DATAOUT	$V_{CC}$ = 4.75 V to 5.25 V, See Notes 2 and 3	V <sub>CC</sub> -1.85	V <sub>CC</sub> -1.62	V
VOH	High-level output voltage	<u>CLKOUT,</u> CLKOUT	$V_{CC} = 5 V$	V <sub>CC</sub> -1.0		V
V <sub>OL</sub>	Low-level output voltage	<u>CLKOUT,</u> CLKOUT	$V_{CC} = 5 V$	V <sub>CC</sub> -1.6		V
V <sub>O(PP)</sub>	Output voltage swing, PECL	<u>CLKOUT,</u> CLKOUT	V <sub>CC</sub> = 4.75 V to 5.25 V, See Note 3	400		mV
Ιн	High-level input current	<u>DATAIN,</u> DATAIN	$V_{CC} = 5.25 \text{ V}, \qquad V_{I} = 4.45 \text{ V}$			μA
١L	Low-level input current	<u>DATAIN,</u> DATAIN	$V_{CC} = 5.25 \text{ V}, \qquad V_{I} = 3.35 \text{ V}$			μA
	Supply current		$V_{CC}$ = 5.25 V, f = 622.08 Mbit/s, Outputs open		107	~^
lcc			V <sub>CC</sub> = 5.25 V, f = 622.08 Mbit/s, See Note 4		107	mA

NOTES: 2. The algebraic convention, in which the least positive (most negative) value is designated minimum, is used in this data sheet for logic-level voltages only.

3. PECL outputs are terminated through a 50- $\Omega$  resistor to V<sub>CC</sub> –2 V.

4. CLKOUT, CLKOUT, DATAOUT, and DATAOUT each are terminated with a 50-Ω resistor to V<sub>CC</sub> - 2 V.

### operating characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Acquisition time	See Note 5				ms
Deviation of clock-sampling point, t <sub>CSP</sub>	See Figure 1				ps
RMS jitter, recovered clock	See Note 6				ps
Peak-to-peak jitter, recovered clock					ps
Input data rate			622.08		Mbit/s
Duty cycle, recovered clock	See Note 3	45%		55%	
Maximum number of consecutive bits (1 or 0) in input data stream	See Note 7				

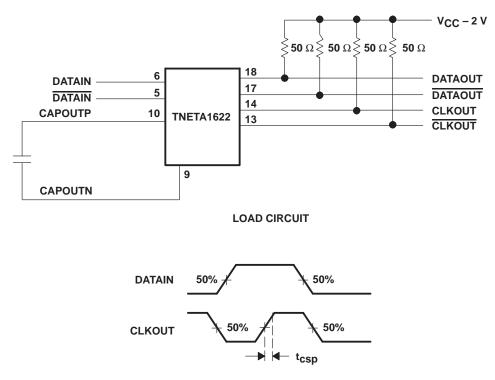
NOTES: 3. PECL outputs are terminated through a 50- $\Omega$  resistor to V<sub>CC</sub> – 2 V.

Acquisition time is the time required to achieve a valid clock output while applying a 2<sup>7</sup> - 1 pseudo-random bit sequence.
 RMS jitter is measured with a 2<sup>31</sup> - 1 pseudo-random bit sequence.
 This measurement is made with a 2<sup>13</sup> - 1 pseudo-random bit sequence with string substitution.



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## PARAMETER MEASUREMENT INFORMATION

**VOLTAGE WAVEFORMS** 

Figure 1. Load Circuit and Voltage Waveforms



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